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ECL Products	

100136

Counter/Shift Register

FEATURES

- Typical propagation delay: 1.8ns
- Typical supply current ($-I_{EE}$): 210mA

DESCRIPTION

The 100136 functions as a four-bit counter or as a 4-bit, bidirectional shift register. These functions are determined by the three Select Inputs $S_0 - S_2$, which also allow for parallel loading, as well as complementing, clearing and holding the register contents.

In the Parallel Load mode, data can be entered into the register via the Preset inputs ($P_0 - P_3$). Outputs $Q_0 - Q_3$ reflect the state of the register, $\bar{Q}_0 - \bar{Q}_3$ give the complement of that state. A High signal on the Master Reset input will clear the value of the register contents to zero asynchronously and without regard for signals at

the other inputs.

When using the 100136 in the Count Up mode, the Terminal Count output (TC) goes Low when the register reaches a value of 15. In the Count Down mode, TC goes Low when the register reaches a value of zero.

When operating the 100136 in the Right Shift mode, D_0/\bar{CET} serves as the serial data input. In the Left Shift mode, D_3 serves as the serial input. When shifting, the TC output has the same level as the Q_3 output.

Two count enable inputs (\bar{CEP} and D_0/\bar{CET}) can be used in combination with the TC output to cascade more than one 100136, allowing for counting and shift capability of eight bits or more. The dual nature of the TC/ Q_3 outputs and the D_0/\bar{CET} input allow the same control lines, inter connected between stages, to be used for

either the Count or the Right Shift operation.

Unused inputs must be tied to low voltage, either V_{IL} or V_{EE} .

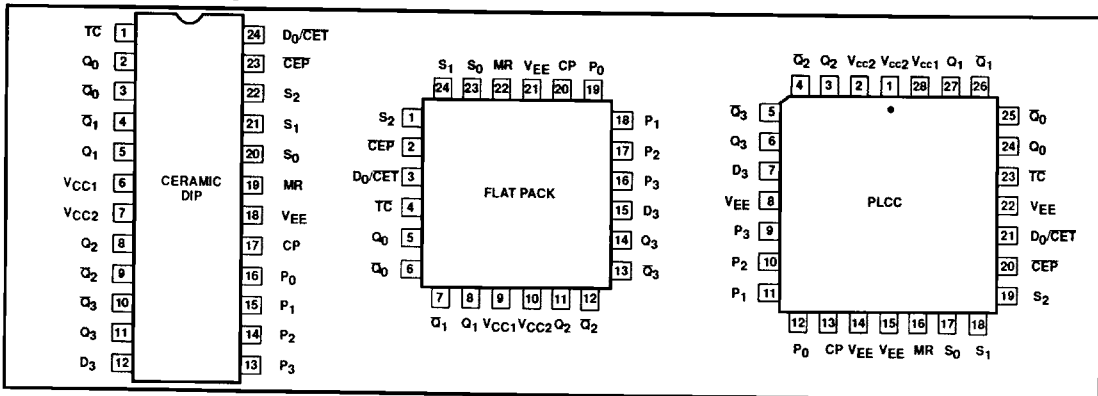
PIN DESCRIPTION

PINS	DESCRIPTION
D_3	Serial Data Inputs (Left Shift)
$P_0 - P_3$	Preset Inputs
CP	Clock Input
D_0/\bar{CET}	Serial Data Input (Right Shift) and Count Enable Trickle Input (Active-Low)
\bar{CEP}	Count Enable Parallel Input (Active-Low)
$S_0 - S_2$	Select Inputs
MR	Master Reset Input
TC	Terminal Count Output
$Q_0 - Q_3$	Data Outputs

ORDERING INFORMATION

DESCRIPTION	ORDER CODE
24-Pin Ceramic DIP (400 mils wide)	100136F
24-Pin Ceramic Flat Pack	100136Y
28-Pin PLCC	100136A

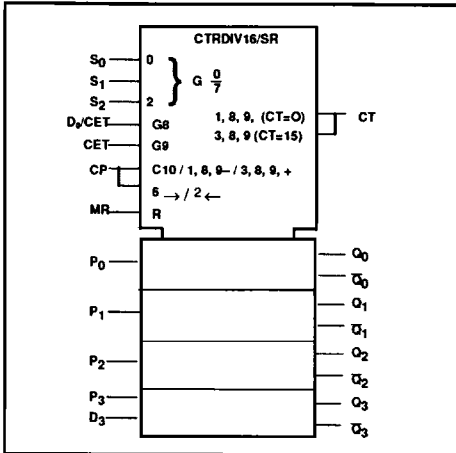
PIN CONFIGURATIONS



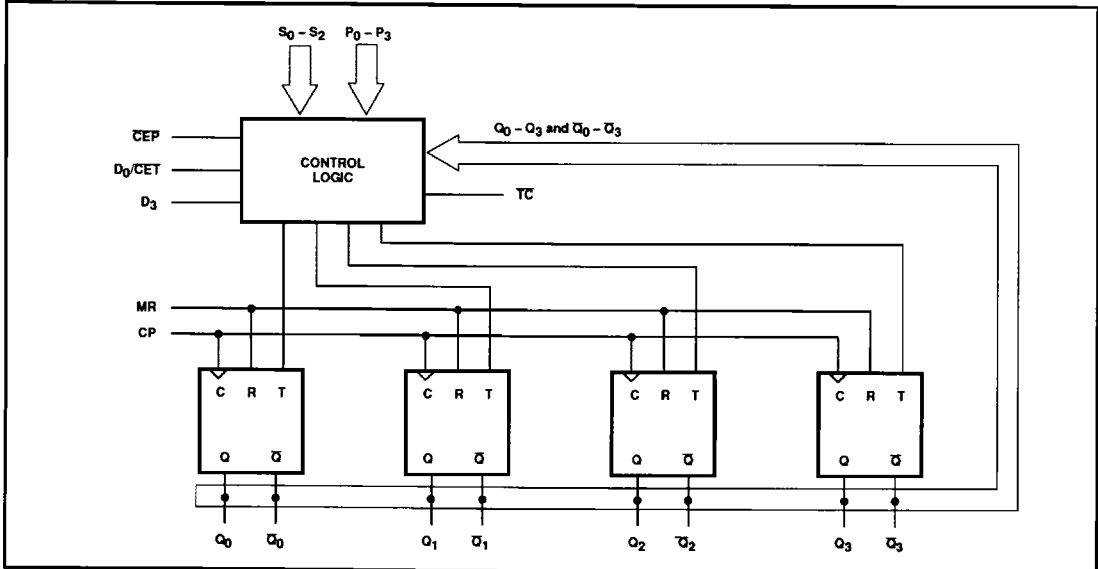
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IEC/IEEE SYMBOL



LOGIC DIAGRAM



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FUNCTION TABLE

INPUTS								OUTPUTS					MODE
MR	S ₂	S ₁	S ₀	CEP	D ₀ /CET	D ₃	CP	Q ₀	Q ₁	Q ₂	Q ₃	TC	
L	L	L	L	X	X	X	↑	P ₀	P ₁	P ₂	P ₃	L	Parallel Load
L	L	L	H	X	X	X	↑	\bar{Q}_0	\bar{Q}_1	\bar{Q}_2	\bar{Q}_3	L	Complement
L	L	H	L	X	X	L	↑	Q ₁	Q ₂	Q ₃	L	L	Left Shift
L	L	H	L	X	X	H	↑	Q ₁	Q ₂	Q ₃	H	H	(D ₃ is the active serial input)
L	L	H	H	X	L	X	↑	L	Q ₀	Q ₁	Q ₂	Q ₂ *	Right Shift
L	L	H	H	X	H	X	↑	H	Q ₀	Q ₁	Q ₂	Q ₂ *	(D ₀ /CET is the active serial input)
L	H	L	L	L	L	X	↑	(Q ₀₋₃) minus 1				(1)	Count Down
L	H	L	L	H	L	X	X	Q ₀	Q ₁	Q ₂	Q ₃	(1)	Count Down disabled with CEP High
L	H	L	L	X	H	X	X	Q ₀	Q ₁	Q ₂	Q ₃	H	Count Down disabled with D ₀ /CET High
L	H	L	H	X	X	X	↑	L	L	L	L	H	Clear
L	H	H	L	L	L	X	↑	(Q ₀₋₃) plus 1				(2)	Count Up
L	H	H	L	H	L	X	X	Q ₀	Q ₁	Q ₂	Q ₃	(2)	Count Up disabled with CEP High
L	H	H	L	X	H	X	X	Q ₀	Q ₁	Q ₂	Q ₃	H	Count Up disabled with D ₀ /CET High
L	H	H	H	X	X	X	X	Q ₀	Q ₁	Q ₂	Q ₃	H	Hold
H	L	L	L	X	X	X	X	L	L	L	L	L	Asynchronous Master Reset
H	L	L	L	X	X	X	X	L	L	L	L	L	
H	L	L	L	X	X	X	X	L	L	L	L	L	
H	L	L	L	X	X	X	X	L	L	L	L	L	
H	L	L	L	X	L	X	X	L	L	L	L	L	
H	L	L	L	X	H	X	X	L	L	L	L	H	
H	L	L	L	X	X	X	X	L	L	L	L	H	
H	L	L	L	X	X	X	X	L	L	L	L	H	
H	L	L	L	X	X	X	X	L	L	L	L	H	

NOTES:

(1) = L if Q₀ - Q₃ = LLLL, H if Q₀ - Q₃ ≠ LLLL(2) = L if Q₀ - Q₃ = HHHH, H if Q₀ - Q₃ ≠ HHHH

H = High voltage level

L = Low voltage level

X = Don't care

↑ = Low-to-High transition

* Before the clock, TC is Q₃; after the clock, TC is Q₂

FUNCTION SELECT TABLE

S ₂	S ₁	S ₀	FUNCTION
L	L	L	Parallel Load
L	L	H	Complement
L	H	L	Left Shift
L	H	H	Right Shift
H	L	L	Count Down
H	L	H	Clear
H	H	L	Count Up
H	H	H	Hold

NOTES:

H = High voltage level

L = Low voltage level

ABSOLUTE MAXIMUM RATINGS V_{CC1} = V_{CC2} = ground, T_A = 0°C to +85°C unless otherwise specified.

SYMBOL	PARAMETER	LIMITS	UNIT
V _{EE}	Supply voltage range	-7.0 to +0.5	V
V _{IN}	Input voltage (V _{IN} should never be more negative than V _{EE})	V _{EE} to +0.5	V
I _O	Output source current (continuous)	-55	mA
T _S	Storage temperature range	-65 to +150	°C
T _J	Maximum junction temperature	+150	°C

NOTE:

Operation beyond the limits set forth in this table may impair the useful life of the device.

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DC OPERATING CONDITIONS

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			MIN.	NOM.	MAX.	
V_{CC1}, V_{CC2}	Circuit ground		0	0	0	V
V_{EE}	Supply voltage		-4.8	-4.5	-4.2	V
V_{EE}	Supply voltage when operating with the 10K or 10KH ECL family		-5.7			V
V_{IH}	High level input voltage	$V_{EE} = -4.2V$	-1150			mV
		$V_{EE} = -4.5V$	-1165		-880	
		$V_{EE} = -4.8V$	-1165			
V_{IL}	Low level input voltage	$V_{EE} = -4.2V$			-1475	mV
		$V_{EE} = -4.5V$	-1810		-1475	mV
		$V_{EE} = -4.8V$			-1490	mV
T_A	Operating ambient temperature range		0	+25	+85	°C

NOTE:

When operating at other than the specified V_{EE} voltages (-4.2V, -4.5V, -4.8V), the DC and AC electrical characteristics will vary slightly from their specified values.

DC ELECTRICAL CHARACTERISTICS $V_{CC1} = V_{CC2} = \text{ground}, V_{EE} = -4.8V \text{ to } -4.2V, T_A = 0^\circ\text{C to } +85^\circ\text{C}$ unless otherwise specified^{1,3,4}

SYMBOL	PARAMETER	TEST CONDITIONS ²	LIMITS			UNIT	
			MIN.	TYP.	MAX.		
V_{OH}	High level output voltage	Inputs at V_{IHMAX} or V_{ILMIN}	$V_{EE} = -4.2V$	-1020		-870	mV
			$V_{EE} = -4.5V$	-1025	-955	-880	mV
			$V_{EE} = -4.8V$	-1035		-880	mV
V_{OHT}	High level output threshold voltage	Outputs loaded with 50Ω	Apply V_{IHMIN} or V_{ILMAX} to one input at a time. Other inputs at V_{IHMAX} or V_{ILMIN} .	$V_{EE} = -4.2V$	-1030		mV
			$V_{EE} = -4.5V$	-1035		mV	
			$V_{EE} = -4.8V$	-1045		mV	
V_{OLT}	Low level output threshold voltage	to -2.0V ±0.010V	Apply V_{IHMIN} or V_{ILMAX} to one input at a time. Other inputs at V_{IHMAX} or V_{ILMIN} .	$V_{EE} = -4.2V$		-1595	mV
			$V_{EE} = -4.5V$		-1610	mV	
			$V_{EE} = -4.8V$		-1610	mV	
V_{OL}	Low level output voltage	Inputs at V_{IHMAX} or V_{ILMIN} .	$V_{EE} = -4.2V$	-1810		-1605	mV
			$V_{EE} = -4.5V$	-1810	-1705	-1620	mV
			$V_{EE} = -4.8V$	-1830		-1620	mV
I_{IH}	High level input current	One input under test at V_{IHMAX} . Other inputs at V_{ILMIN} .	P_n, S_n			180	μA
			CEP			200	μA
			MR			240	μA
			D_3			280	μA
			CP			390	μA
			D_0/CET			530	μA
I_{IL}	Low level input current	One input under test at V_{ILMIN} . Other inputs at V_{IHMAX} .	0.5			μA	
$-I_{EE}$	V_{EE} supply current	All inputs at V_{IHMAX}	136	210	283	mA	

NOTES:

1. The specified limits represent the worst case values for the parameter. Since these worst case values normally occur at the supply voltage

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NOTES (CONTINUED):

- and temperature extremes, additional noise immunity can be achieved by decreasing the allowable operating condition ranges.
- Conditions for testing shown in the tables are not necessarily worst case. For worst case testing guidelines, refer to DC Testing, Chapter 1, Section 3.
 - The specified limits shown in the DC electrical characteristics table can be met only after thermal equilibrium has been established. Thermal equilibrium is established by applying power for at least 2 minutes, while maintaining transverse airflow of 2.5 meters/sec (500 linear feet/min) over the device, mounted either in a test socket or on a printed circuit board. Test voltage values are given in the DC operating conditions table.
 - The device can function down to $V_{EE} = -5.7V$, allowing operation with either the 10K or the 10KH family. Correction factors can be used to calculate new DC limits for the extended V_{EE} range. For more information, see Chapters 5 and 10, Section 4.

AC ELECTRICAL CHARACTERISTICS

Ceramic DIP $V_{CC1} = V_{CC2} = \text{ground}$, $V_{EE} = -4.8V$ to $-4.2V$

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS						UNIT	
			$T_A = 0^\circ C$		$T_A = +25^\circ C$		$T_A = +85^\circ C$			
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
f_{MAX}	Maximum shift frequency CP	Waveform 1	250		250		250		MHz	
t_{PLH} t_{PHL}	Propagation delay CP to Q_n , \bar{Q}_n	Waveforms 1,2	0.85	2.10	0.85	2.10	0.85	2.25	ns	
t_{PLH} t_{PHL}	Propagation delay CP to TC		0.85	2.10	0.85	2.10	0.85	2.25	ns	
t_{PLH} t_{PHL}	Propagation delay CP to TC	Waveform 2	1.80	4.80	1.80	4.60	1.80	5.20	ns	
t_{PLH} t_{PHL}	Propagation delay MR to Q_n , \bar{Q}_n		1.80	4.80	1.80	4.60	1.80	5.20	ns	
t_{PLH} t_{PHL}	Propagation delay MR to TC	Waveform 2	1.20	2.95	1.35	2.95	1.20	3.10	ns	
t_{PLH} t_{PHL}	Propagation delay MR to TC		1.20	2.95	1.35	2.95	1.20	3.10	ns	
t_{PLH} t_{PHL}	Propagation delay MR to TC	Waveform 3	2.10	4.80	2.10	4.80	2.10	5.00	ns	
t_{PLH} t_{PHL}	Propagation delay MR to TC		2.10	4.80	2.10	4.80	2.10	5.00	ns	
t_{PLH} t_{PHL}	Propagation delay D_0/CET to TC	Waveform 3	1.40	3.20	1.40	3.20	1.40	3.50	ns	
t_{PLH} t_{PHL}	Propagation delay D_0/CET to TC		1.40	3.20	1.40	3.20	1.40	3.50	ns	
t_{PLH} t_{PHL}	Propagation delay S_n to TC	Waveform 3	1.40	4.60	1.60	4.60	1.60	4.80	ns	
t_{PLH} t_{PHL}	Propagation delay S_n to TC		1.40	4.60	1.60	4.60	1.60	4.80	ns	
t_{TLH} t_{THL}	Transition time Q_n , \bar{Q}_n , TC	Waveform 1	0.45	1.80	0.45	1.80	0.45	1.80	ns	
t_s	Setup time D_3 to CP	Waveform 2	0.45	1.80	0.45	1.80	0.45	1.80	ns	
t_h	Hold time CP to D_3		1.40		1.40		1.40		ns	
t_s	Setup time P_n to CP		0.20		0.20		0.20		ns	
t_h	Hold time CP to P_n		1.70		1.70		1.70		ns	
t_s	Setup time D_0/CET , CEP to CP		0.10		0.10		0.10		ns	
t_h	Hold time CP to D_0/CET , CEP		1.80		1.80		1.80		ns	
t_s	Setup time S_n to CP		0.20		0.20		0.20		ns	
t_h	Hold time CP to S_n		3.80		3.80		3.80		ns	
t_R	Release time MR to CP		-0.9		-0.9		-0.9		ns	
$t_w(H)$	Pulse width High, MR, CP		2.50		2.50		2.50		ns	
$t_w(H)$	Pulse width High, MR, CP		Waveforms 1,2	2.00		2.00		2.00		ns

NOTE:

For AC test setup information, see AC Testing, Chapter 2, Section 3.

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AC ELECTRICAL CHARACTERISTICS

Ceramic DIP $V_{CC1} = V_{CC2} = \text{ground}$, $V_{EE} = -5.2V \pm 5\%$

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS						UNIT
			$T_A = 0^\circ\text{C}$		$T_A = +25^\circ\text{C}$		$T_A = +85^\circ\text{C}$		
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
f_{MAX}	Maximum shift frequency CP	Waveform 1	250		250		250		MHz
t_{PLH} t_{PHL}	Propagation delay CP to Q_n , \bar{Q}_n	Waveforms 1,2	0.85	2.10	0.85	2.10	0.85	2.25	ns
			0.85	2.10	0.85	2.10	0.85	2.25	ns
t_{PLH} t_{PHL}	Propagation delay CP to TC	Waveform 2	1.80	4.80	1.80	4.60	1.80	5.20	ns
			1.80	4.80	1.80	4.60	1.80	5.20	ns
t_{PLH} t_{PHL}	Propagation delay MR to Q_n , \bar{Q}_n	Waveform 2	1.20	2.95	1.35	2.95	1.20	3.10	ns
			1.20	2.95	1.35	2.95	1.20	3.10	ns
t_{PLH} t_{PHL}	Propagation delay MR to TC	Waveform 2	2.10	4.80	2.10	4.80	2.10	5.00	ns
			2.10	4.80	2.10	4.80	2.10	5.00	ns
t_{PLH} t_{PHL}	Propagation delay D_0/CET to TC	Waveform 3	1.40	3.20	1.40	3.20	1.40	3.50	ns
			1.40	3.20	1.40	3.20	1.40	3.50	ns
t_{PLH} t_{PHL}	Propagation delay S_n to TC	Waveform 3	1.40	4.60	1.60	4.60	1.60	4.80	ns
			1.40	4.60	1.60	4.60	1.60	4.80	ns
t_{TLH} t_{THL}	Transition time Q_n , \bar{Q}_n , TC	Waveform 1	0.45	1.80	0.45	1.80	0.45	1.80	ns
			0.45	1.80	0.45	1.80	0.45	1.80	ns
t_s	Setup time D_3 to CP	Waveform 2	1.40		1.40		1.40		ns
t_h	Hold time CP to D_3		0.20		0.20		0.20		ns
t_s	Setup time P_n to CP		1.70		1.70		1.70		ns
t_h	Hold time CP to P_n		0.10		0.10		0.10		ns
t_s	Setup time D_0/CET , CEP to CP		1.80		1.80		1.80		ns
t_h	Hold time CP to D_0/CET , CEP		0.20		0.20		0.20		ns
t_s	Setup time S_n to CP		3.80		3.80		3.80		ns
t_h	Hold time CP to S_n		-0.9		-0.9		-0.9		ns
t_R	Release time MR to CP		2.50		2.50		2.50		ns
$t_w(\text{H})$	Pulse width High, MR, CP		Waveforms 1,2	2.00		2.00		2.00	

NOTE:

For AC test setup information, see AC Testing, Chapter 2, Section 3.

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AC ELECTRICAL CHARACTERISTICS

Flat Pack and PLCC $V_{CC1} = V_{CC2} = \text{ground}$, $V_{EE} = -4.8\text{V}$ to -4.2V

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS						UNIT
			$T_A = 0^\circ\text{C}$		$T_A = +25^\circ\text{C}$		$T_A = +85^\circ\text{C}$		
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
f_{MAX}	Maximum shift frequency CP	Waveform 1	250		250		250		MHz
t_{PLH} t_{PHL}	Propagation delay CP to Q_n , \bar{Q}_n	Waveforms 1,2	0.85	2.15	0.85	2.15	0.85	2.30	ns
t_{PLH} t_{PHL}	Propagation delay CP to TC		0.85	2.15	0.85	2.15	0.85	2.30	ns
t_{PLH} t_{PHL}	Propagation delay CP to TC	Waveform 2	1.80	4.60	1.80	4.40	1.80	5.00	ns
t_{PLH} t_{PHL}	Propagation delay MR to Q_n , \bar{Q}_n		1.80	4.60	1.80	4.40	1.80	5.00	ns
t_{PLH} t_{PHL}	Propagation delay MR to TC	Waveform 3	1.20	2.75	1.35	2.75	1.20	2.90	ns
t_{PLH} t_{PHL}	Propagation delay D ₀ /CET to TC		1.20	2.75	1.35	2.75	1.20	2.90	ns
t_{PLH} t_{PHL}	Propagation delay S _n to TC	Waveform 1	2.10	4.60	2.10	4.60	2.10	4.80	ns
t_{PLH} t_{PHL}	Propagation delay D ₀ /CET to TC		2.10	4.60	2.10	4.60	2.10	4.80	ns
t_{PLH} t_{PHL}	Propagation delay S _n to TC	Waveform 2	1.40	3.00	1.40	3.00	1.40	3.30	ns
t_{PLH} t_{PHL}	Propagation delay S _n to TC		1.40	3.00	1.40	3.00	1.40	3.30	ns
t_{TLH} t_{THL}	Transition time Q_n , \bar{Q}_n , TC	Waveform 1	0.45	1.80	0.45	1.80	0.45	1.80	ns
t_{TLH} t_{THL}	Transition time Q_n , \bar{Q}_n , TC		0.45	1.80	0.45	1.80	0.45	1.80	ns
t_s	Setup time D ₃ to CP	Waveform 2	1.40		1.40		1.40		ns
t_h	Hold time CP to D ₃		0.00		0.00		0.00		ns
t_s	Setup time P _n to CP		1.60		1.60		1.60		ns
t_h	Hold time CP to P _n		0.00		0.00		0.00		ns
t_s	Setup time D ₀ /CET, CEP to CP		1.80		1.80		1.80		ns
t_h	Hold time CP to D ₀ /CET, CEP		0.00		0.00		0.00		ns
t_s	Setup time S _n to CP		3.60		3.60		3.60		ns
t_h	Hold time CP to S _n		-0.4		-0.4		-0.4		ns
t_R	Release time MR to CP		2.50		2.50		2.50		ns
$t_w(\text{H})$	Pulse width High, MR, CP		Waveforms 1,2	2.00		2.00		2.00	

NOTE:

For AC test setup information, see AC Testing, Chapter 2, Section 3.

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AC ELECTRICAL CHARACTERISTICS

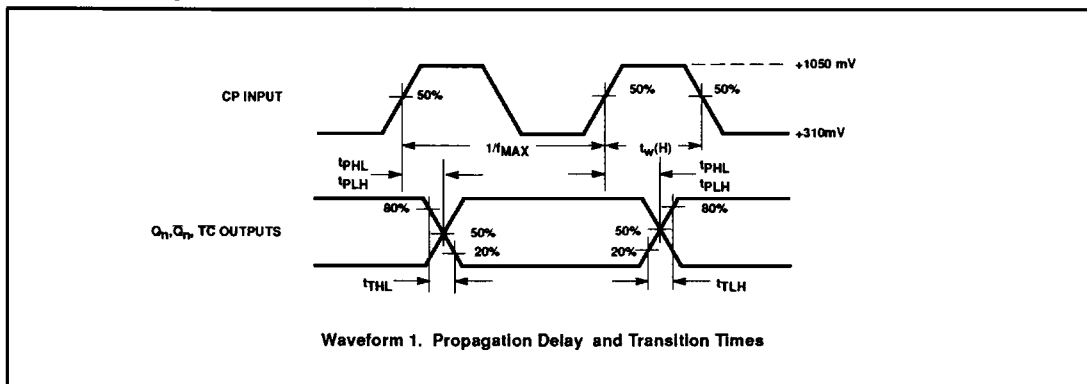
Flat Pack and PLCC $V_{CC1} = V_{CC2} = \text{ground}$, $V_{EE} = -5.2V \pm 5\%$

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS						UNIT
			$T_A = 0^\circ\text{C}$		$T_A = +25^\circ\text{C}$		$T_A = +85^\circ\text{C}$		
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
f_{MAX}	Maximum shift frequency CP	Waveform 1	250		250		250		MHz
t_{PLH} t_{PHL}	Propagation delay CP to Q_n, \bar{Q}_n	Waveforms 1,2	0.85	2.15	0.85	2.15	0.85	2.30	ns
t_{PLH} t_{PHL}	Propagation delay CP to TC		1.80	4.60	1.80	4.40	1.80	5.00	ns
t_{PLH} t_{PHL}	Propagation delay MR to Q_n, \bar{Q}_n	Waveform 2	1.20	2.75	1.35	2.75	1.20	2.90	ns
t_{PLH} t_{PHL}	Propagation delay MR to TC		2.10	4.60	2.10	4.60	2.10	4.80	ns
t_{PLH} t_{PHL}	Propagation delay D_0/\bar{CET} to TC	Waveform 3	1.40	3.00	1.40	3.00	1.40	3.30	ns
t_{PLH} t_{PHL}	Propagation delay S_n to TC		1.40	4.60	1.60	4.60	1.60	4.80	ns
t_{TLH} t_{THL}	Transition time Q_n, \bar{Q}_n, TC	Waveform 1	0.45	1.80	0.45	1.80	0.45	1.80	ns
t_s	Setup time D_3 to CP	Waveform 2	1.40		1.40		1.40		ns
t_h	Hold time CP to D_3		0.00		0.00		0.00		ns
t_s	Setup time P_n to CP		1.60		1.60		1.60		ns
t_h	Hold time CP to P_n		0.00		0.00		0.00		ns
t_s	Setup time $D_0/\bar{CET}, \bar{C}EP$ to CP		1.80		1.80		1.80		ns
t_h	Hold time CP to $D_0/\bar{CET}, \bar{C}EP$		0.00		0.00		0.00		ns
t_s	Setup time S_n to CP		3.60		3.60		3.60		ns
t_h	Hold time CP to S_n		-0.4		-0.4		-0.4		ns
t_R	Release time MR to CP		2.50		2.50		2.50		ns
$t_w(H)$	Pulse width High, MR, CP		Waveforms 1,2	2.00		2.00		2.00	

NOTE:

For AC test setup information, see AC Testing, Chapter 2, Section 3.

AC WAVEFORMS



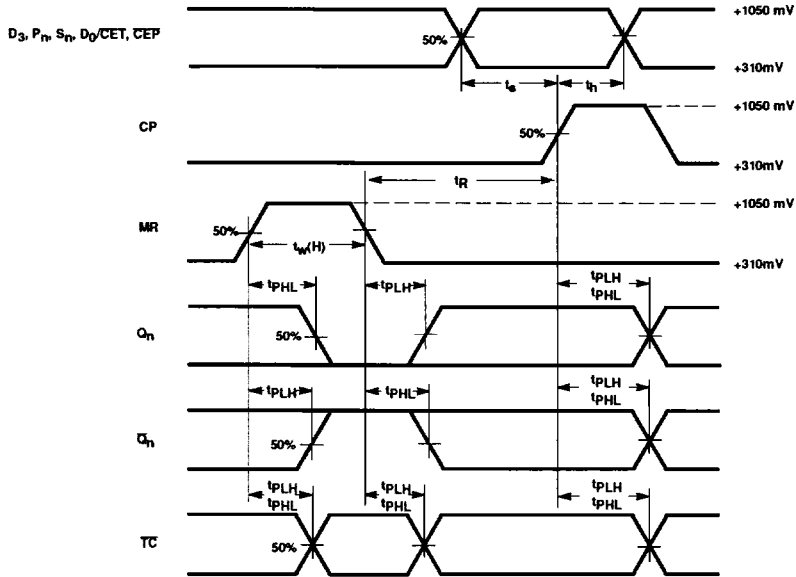
NOTE:

All power and signal voltages shifted up 2.0V for AC bench test purposes.

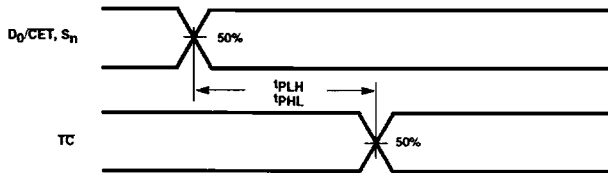
Counter/Shift Register

100136

AC WAVEFORMS



Waveform 2. Reset, Setup and Hold Times



Waveform 3. Data Setup and Hold Times

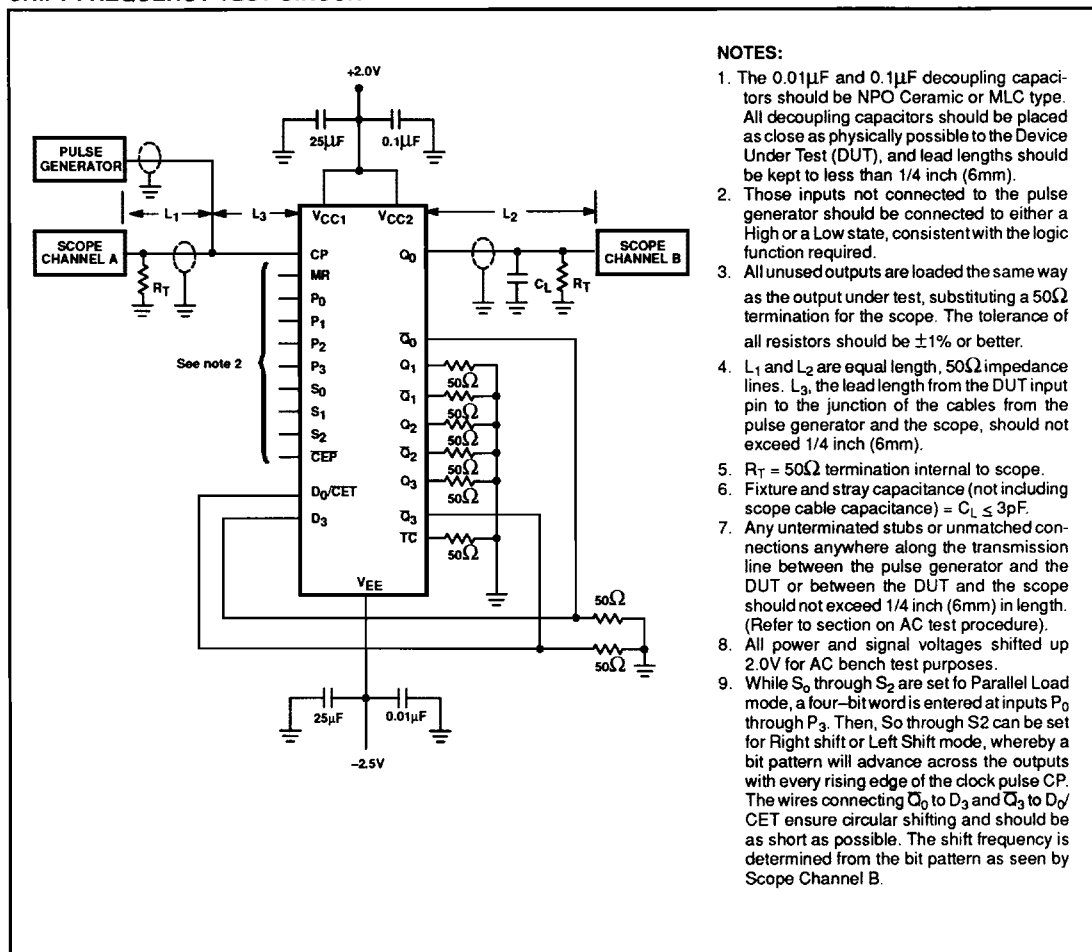
NOTE:

All power and signal voltages shifted up 2.0V for AC bench test purposes.

Counter/Shift Register

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SHIFT FREQUENCY TEST CIRCUIT

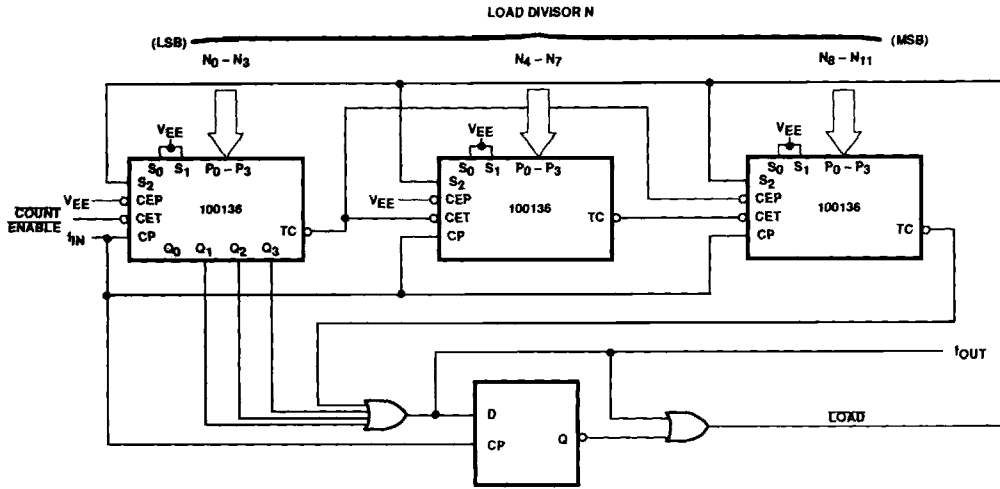


Counter/Shift Register

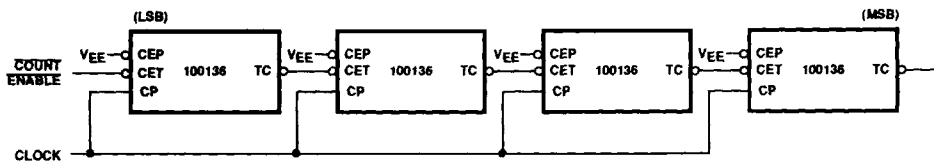
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APPLICATION CIRCUITS

3-STAGE DIVIDER USING PARALLEL LOAD AND COUNT DOWN MODES



SLOW EXPANSION SCHEME FOR COUNTING AND RIGHT SHIFT



FAST EXPANSION SCHEME FOR COUNTING

